### **Electronic Supplementary Information:**

Thermally driven bubble evolution at a heater wire in water characterized by high-speed transmission electron microscopy

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## Thermodynamic modeling:

The vapor pressures of 1 mM dissolved  $O_2$ ,  $N_2$ , and  $H_2$  as functions of temperature are shown in Fig. S5. These were calculated using a Henry's law treatment. Temperature dependent Henry's law coefficients were calculated from data in [<sup>1</sup>] with the van 't Hoff equation:

$$\frac{d\ln H}{d(1/T)} = \frac{-\Delta H_{sol}}{R},$$

where H is the Henry solubility (dissolved concentration/vapor pressure), T is temperature, R is the gas constant, and  $-\Delta H_{sol}$  is the enthalpy of dissolution. The vapor pressure of water as a function of temperature was calculated using the Antoine equation:

$$\log\left(p\right) = a - \left(\frac{b}{T-c}\right),$$

where a, b, and c are parameters extracted from [2].

## **References:**

- 1 R. Sander, Atmos. Chem. Phys., 2015, 15, 4399–4981.
- 2 D. R. Stull, Ind. Eng. Chem., 1947, **39**, 540–550.
- 3 M. T. Alam, M. P. Manoharan, M. A. Haque, C. Muratore and A. Voevodin, *J. Micromech. Microeng.*, 2012, **22**, 45001.

## **Supplementary Video:**

Video S1 shows the first 125 ms of bubble evolution in experiments A-E, at heater wire voltages of 0.10, 0.50, and 1.00 V (speed = 1/80 \* real time).

# **Supplementary Figures:**

(a)



SiO2 mask

Pt electrical traces

Fig. S1: (a) Low magnification scanning electron micrograph of  $SiN_x$  window chip prior to heater wire deposition, (b) scanning electron micrograph of  $SiN_x$  window with heater wire and electrical traces. The heater wire is powered by applying a voltage across the two outer traces; the middle trace is not biased. The sample is tilted at 45° to show the relative topography.

μm

10



Fig. S2: Schematic of the employed experimental setup and electron beam path. The liquid layer thickness is ~500-1000 nm.



Fig. S3: (a) Transmission electron micrograph showing defects in the middle Pt trace, (b) image sequence, 2.5 ms apart, showing heater wire destruction and subsequent bubble nucleation at large heater power.



Fig. S4: Steady state temperature profile of the window (bottom view) with heater wire (modeled in COMSOL), voltage = 0.10 V, and liquid layer thickness of 750 nm, assuming thermal conductivities in water and  $SiN_x$  of 0.6 and 2.0 W m<sup>-1</sup> K<sup>-1</sup> [<sup>3</sup>], and no electrical resistance in the middle Pt trace. Inset shows a merged transmission electron micrograph of the experimental system with overlaid temperature profile.



Fig. S5: Partial pressure of dissolved 1 mM  $H_2$ ,  $O_2$ , and  $N_2$  using a Henry's Law treatment and saturated water vapor vs. temperature.



Fig. S6: (a) Image series showing Ostwald ripening and subsequent bubble collapse in experiment C, (b) the diameters of the two bubbles with time.